

UNITED STATES PATENT AND TRADEMARK OFFICE

W

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER OF PATENTS AND TRADEMARKS Washington, D.C. 20231 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/966,046	09/28/2001	Karl Mautz	SC0194WD	4300	
75	90 11/19/2002				
Jim Clingan Motorola, Inc. Austin Intellectual Property Law Section			EXAMINER		
			BLUM, DAVID S		
7700 West Parmer Lane Austin, TX 78729			ART UNIT	PAPER NUMBER	
,	, = ,		2813	6	
			DATE MAILED: 11/19/2002	$\boldsymbol{\psi}$	

Please find below and/or attached an Office communication concerning this application or proceeding.

				(!/n
	•	Application No.	Applicant(s)	(000
Office Action Summary		09/966,046	MAUTZ ET AL.	
		Examiner	Art Unit	· · · · · · · · · · · · · · · · · · ·
		David S Blum	2813	
Period fo	The MAILING DATE of this communication app r Reply	ars on the cover sheet with	the correspondence addr	ess
THE N - Exten after: - If the - If NO - Failur - Any re	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. Issions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. Period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period veron to reply within the set or extended period for reply will, by statute, eply received by the Office later than three months after the mailing dipatent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a rep within the statutory minimum of thirty (will apply and will expire SIX (6) MONTH cause the application to become ABAN	ly be timely filed 30) days will be considered timely. IS from the mailing date of this community (NONED (35 U.S.C. § 133).	nunication.
1)⊠	Responsive to communication(s) filed on 01 C	October 2002 .		
2a)□	This action is FINAL . 2b)⊠ Thi	is action is non-final.		
3) <mark>∐</mark> Dispositie	Since this application is in condition for allowal closed in accordance with the practice under a con of Claims			merits is
4)🖂	Claim(s) 1-15 is/are pending in the application			
4	4a) Of the above claim(s) is/are withdrav	vn from consideration.		
5)	Claim(s) is/are allowed.			
6)⊠	Claim(s) <u>1,3-9 and 11-15</u> is/are rejected.			
7)🖂	Claim(s) <u>2 and 10</u> is/are objected to.			
	Claim(s) are subject to restriction and/or on Papers	election requirement.		
	The specification is objected to by the Examiner			
·	he drawing(s) filed on 28 September 2001 is/a		ected to by the Evaminer	
10/23 1	Applicant may not request that any objection to the	•	•	
11)∏ T	The proposed drawing correction filed on			
,	If approved, corrected drawings are required in rep	•	approved by the Examiner.	
12) <u></u> ⊤	he oath or declaration is objected to by the Exa	•		
•	nder 35 U.S.C. §§ 119 and 120			
	Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. & 1	19(a)-(d) or (f)	
_	☐ All b) ☐ Some * c) ☐ None of:	priority arrast of c.c.c. g	10(4) (4) 51 (1).	
•	1.☐ Certified copies of the priority documents	have been received.		
	2. Certified copies of the priority documents		lication No.	
;	3. Copies of the certified copies of the priori	ty documents have been re		age
* Se	application from the International Bur ee the attached detailed Office action for a list o		ceived.	
14) 🗌 Ad	cknowledgment is made of a claim for domestic	priority under 35 U.S.C. §	119(e) (to a provisional ap	plication).
	☐ The translation of the foreign language prov cknowledgment is made of a claim for domestic			
· — \ttachment(
2) 🔲 Notice	of References Cited (PTO-892) of Draftsperson's Patent Drawing Review (PTO-948) ation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Info	nmary (PTO-413) Paper No(s). rmal Patent Application (PTO-1)	
Patent and Tra		ion Summary	Part of Pa	per No. 6

Application/Control Number: 09/966,046

Art Unit: 2813

This action is in response to Amendment A paper #5, filed 10/01/02.

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1, 3-5, 7, 9, and 11-14 are rejected under 35 U.S.C. 102(b) as being anticipated by Katsuyuki (JP 58-169149).

Katsuyuki teaches all of the positive steps of claims 1, 3-5, 7, 9, and 11-14 in that a magnetic means (film 3) having a pattern (2) is formed on a glass substrate which may be on a semiconductor wafer (abstract, constitution) used to provide information such as lot number. The pattern (2, figure 2) shows a series of regions and non-magnetic regions (as in claim 4). The magnetic film is provided at the wafer peripheral (abstract, purpose) as in claim 7. information is written in the film (abstract, constitution) as in claim 13. The film also masks the wafer (abstract, constitution) as in claim 14. The magnetic film is formed by deposition (paragraph 6) as in claim 12.

Regarding the limitations of claims 5 and 11 where the magnetic means comprise regions having different magnetizations (claim 5) and specifically mentioning sputtering (claim 11), figure 2 of Katsuyuki shows the magnetic film with regions of different heights and widths, therefore, showing regions having different magnetizations. Also,

Art Unit: 2813

Katsuyuki teaches forming the film to by deposition, which would include sputtering (sputtering being a conventional deposition method).

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 6 and 15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Katsuyuki (JP 58-169149) in view of Chang (US006197481B1) and Oishi (US006004405A).

Katsuyuki teaches all of the positive steps of claim 5 as recited above except for teaching a protective film over the magnetic film.

Chang teaches forming a protective film over alignment marks to protect the marks from subsequent processing steps (abstract). Although an alignment mark is not the same as an identification mark containing data, it is similar in that it is a mark used in identifying a part of the wafer for processing. It would have been obvious to modify Katsuyuki with the teachings of Chang so that a protective film would provide protection for identifying marks during processing so that the marks could be read.

Oishi teaches various types of marks are used to identify wafers, including notches (alignment marks) and laser marks (background and bar codes column 2 line 4). Thus,

Application/Control Number: 09/966,046

Art Unit: 2813

although the marks carry different information, Oishi teaches them to have an art recognized equivalence.

It would be obvious to one skilled in the requisite art at the time of the invention to modify Katsuyuki by using a protective film as taught by Chang with reasonable expectation of producing an identification mark that is readable after subsequent processing steps.

5. Claim 8 is rejected under 35 U.S.C. 103(a) as being unpatentable over Katsuyuki (JP 58-169149) in view of Oishi (US006004405A).

Katsuyuki teaches all of the positive steps of claim 8 as recited above except for placing the identification mark (information for identification) on the inner region of a wafer where the vacuum chuck would engage the wafer. Oishi teaches forming an identification mark on the wafer side (figure 1A) where it will not interfere with the effective area of the wafer. Therefore it is obvious that the area where the vacuum chuck is employed may be used as the mark area as it is not an effective area (active area) of the wafer, but a peripheral area (constitution). Katsuyuki teaches forming the magnetic means in a peripheral area on the wafer. Thus Katsuyuki is teaching that the magnetic means be placed in an area on the wafer (surface or side) and Oishi teaches that this can be any area which is not an effective (active) area. The area where the chuck engages the wafer in the instant application is a peripheral area on the wafer and not an active area.

Regarding the limitation where the vacuum chuck has magnetic reading capabilities; that is a limitation on the reading apparatus, not the semiconductor device and is given

Art Unit: 2813

no weight. The functional use of the magnetic means does not change whether or not the vacuum chuck can read the magnetic means or a separate piece on the apparatus is used (see MPEP 2114 regarding functional language).

It would have been obvious to one skilled in the requisite art at the time of the invention to modify Katsuyuki by including the vacuum chuck area as part of the peripheral area as taught by Oishi with reasonable expectation of producing an identification mark that is in a peripheral region and does not interfere with the effective production area.

Allowable Subject Matter

6. Claims 2 and 10 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

Claims 2 and 10 limit the device and formation of the device to forming the magnetic means by ion implantation. In the case of claim 2, where the process step of implantation carries little weight, the limitation is viewed as having the magnetic means in the substrate rather than on the substrate. Katsuyuki forms the magnetic means by deposition on the substrate but does not teach or suggest implanting the magnetic means into the substrate.

Response to Arguments

7. Applicant's arguments filed 10/01/02 have been fully considered but they are not persuasive.

Application/Control Number: 09/966,046

Art Unit: 2813

in Control Hamber: corcec,e

The applicant argues that Katsuyuki (JP 58-169149) does not teach forming the

magnetic means on a semiconductor substrate, but only on a translucent glass

substrate, and therefore does not teach all of the positive steps of claims 1-15.

However, in the constitution, Katsuyuki teaches the film carries information about the

kind, lot number, etching conditions, etc. Further, when used in lithographing a

semiconductor wafer (substrate), the film carries information of the kind of mask itself,

lot number, etc. (constitution), thus, the film is on the semiconductor wafer. Thus

Katsuyuki teaches that the magnetic means may be on a glass substrate (as argued by

the applicant) or on a semiconductor wafer.

8. Any inquiry concerning this communication or earlier communications from the

examiner should be directed to David S. Blum whose telephone number is (703)-306-

9168 and e-mail address is David.blum@USPTO.gov.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Carl Whitehead Jr., can be reached at (703)-308-4940. Our facsimile

number for Before-Final Communications is (703)- 872-9318 and for After-Final

Communications is (703)- 872-9319. The facsimile number for customer service is

(703)-872-9317. Our receptionist's number is (703)-308-0956.

David S. Blum

November 18, 2002

UPERVISORY PATENT EXAMINE

TECHNOLOGY CENTER 2800